

## P-Channel Enhancement Mode Field Effect Transistor

### General Description

The CMSA120P03A uses advanced trench technology to provide excellent RDS(ON).

This device is ideal for load switch and battery protection applications.

### Features

- Low On-Resistance
- Simple Drive Requirements
- 100% EAS Guaranteed
- RoHS Compliant

### Product Summary

BVDSS	RDS(ON)	ID
-30V	3.6mΩ	-150A

### Applications

- Load Switch
- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

### DFN-8 5x6 Pin Configuration



### Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-30	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D @ T_C = 25^\circ C$	Continuous Drain Current	-150	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current	-105	A
$I_{DM}$	Pulsed Drain Current	-600	A
EAS	Single Pulse Avalanche Energy <sup>1</sup>	200	mJ
$P_D @ T_C = 25^\circ C$	Total Power Dissipation	78	W
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	150	°C

### Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Junction-to-Ambient(Steady-State)	---	55	°C/W
$R_{\theta JC}$	Junction-to-Case	---	1.6	°C/W

Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=-250\mu\text{A}$	-30	---	---	V
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=-10\text{V}$ , $I_D=-28\text{A}$	---	3.1	3.6	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}$ , $I_D=-25\text{A}$	---	4.2	5	
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$ , $I_D=-250\mu\text{A}$	-1	---	-2	V
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=-24\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=25^\circ\text{C}$	---	---	-1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}}=\pm20\text{V}$ , $V_{\text{DS}}=0\text{V}$	---	---	$\pm100$	nA
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=-10\text{V}$ , $I_D=-20\text{A}$	---	41	---	S
$R_g$	Gate Resistance	$V_{\text{DS}}=0\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	22	---	$\Omega$
$Q_g$	Total Gate Charge	$V_{\text{DS}}=-15\text{V}$ , $I_D=-30\text{A}$	---	135	---	nC
$Q_{\text{gs}}$	Gate-Source Charge		---	12	---	
$Q_{\text{gd}}$	Gate-Drain Charge		---	36	---	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}}=-15\text{V}$ , $V_{\text{GEN}}=-10\text{V}$	---	22	---	ns
$T_r$	Rise Time		---	25	---	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	163	---	
$T_f$	Fall Time		---	104	---	
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=-25\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	5000	---	pF
$C_{\text{oss}}$	Output Capacitance		---	600	---	
$C_{\text{rss}}$	Reverse Transfer Capacitance		---	380	---	

## Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current	$V_G=V_D=0\text{V}$ , Force Current	---	---	-150	A
$I_{\text{SM}}$	Pulsed Source Current		---	---	-600	A
$V_{\text{SD}}$	Diode Forward Voltage	$V_{\text{GS}}=0\text{V}$ , $I_F=-25\text{A}$	---	-0.82	-1.2	V

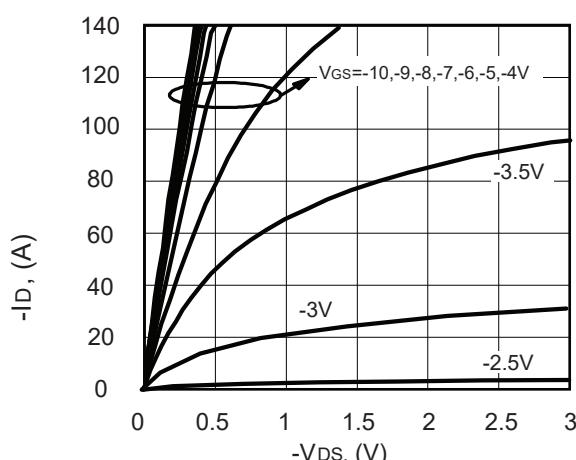
Note :

1.The EAS data shows Max. rating . The test condition is  $V_{\text{DD}}=-25\text{V}$ ,  $V_{\text{GS}}=-10\text{V}$ ,  $L=0.5\text{mH}$ ,  $I_D=-28.3\text{A}$ 

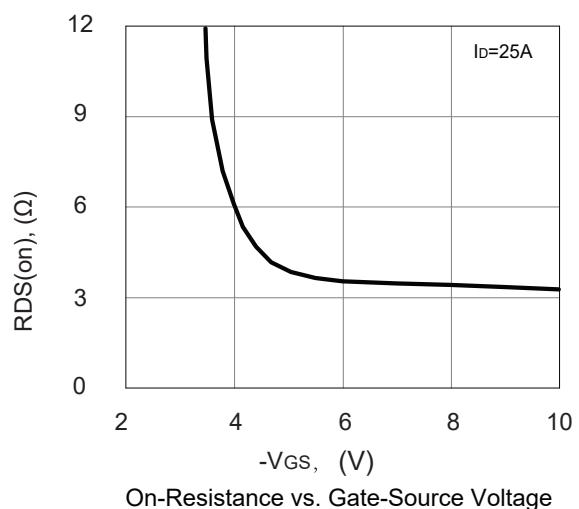
This product has been designed and qualified for the consumer market.

Cmos assumes no liability for customers' product design or applications.

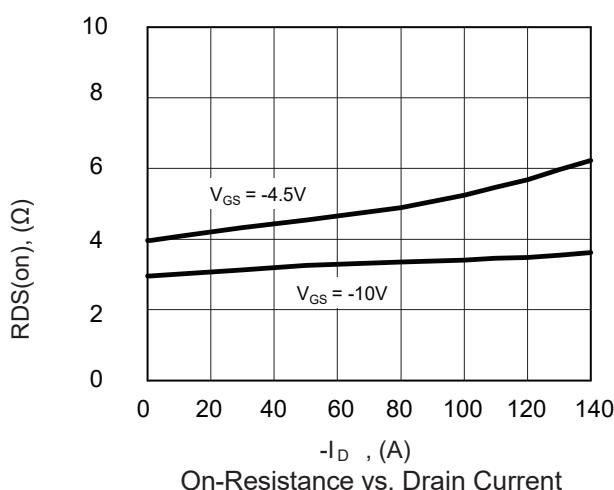
Cmos reserves the right to improve product design ,functions and reliability without notice.

**Typical Characteristics**


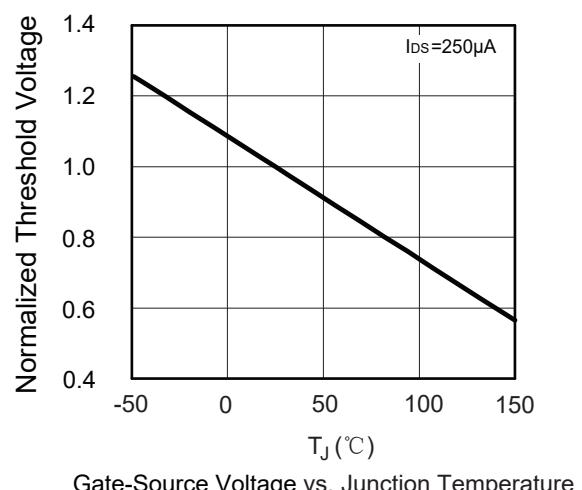
Typical Output Characteristics



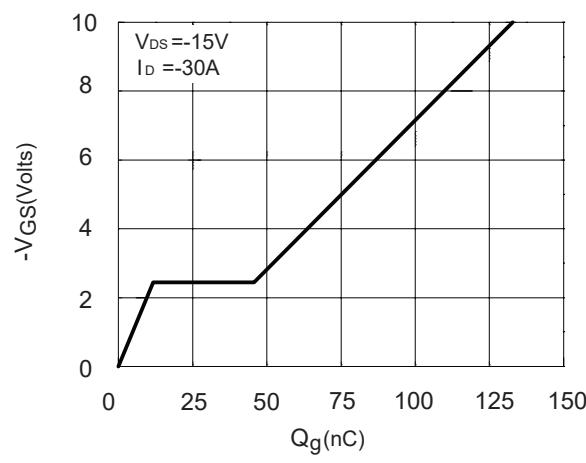
On-Resistance vs. Gate-Source Voltage



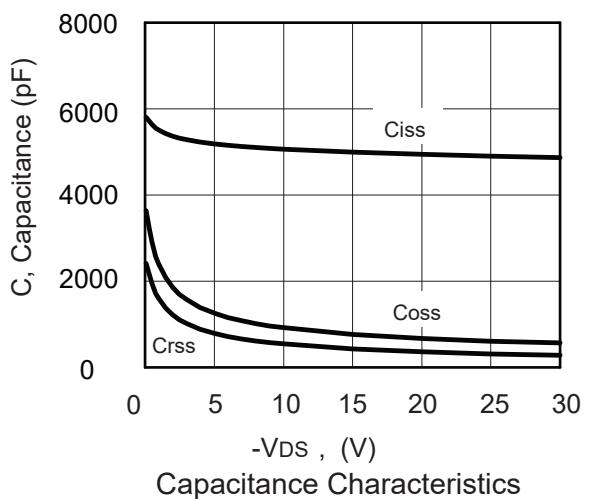
On-Resistance vs. Drain Current



Gate-Source Voltage vs. Junction Temperature



Gate Charge Characteristics



Capacitance Characteristics